

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/049,287	FUJII ET AL.
Examiner	Art Unit	
Edith M. Chang	2611	

SEARCHED			
Class	Subclass	Date	Examiner
375	212 219 220 232 257 356	9/27/05 / / / /	eh
709	235	/	/
370	235-236 312, 432 445-446	/	/
	455	=	=
340	10, 2	=	=
<u>update Search</u>			
439	65, 489	4/3/06	eh
	955)	=

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
375	212, 219 220, 222	8/15/06	ch	
	257, 356			
370	235-236 313, 432			
	445, 446 455			
340	10, 2			
709	255			